

## Features

- ESD protect for 4 high-speed I/O channels
- Provide transient protection for each channel to IEC 61000-4-2 (ESD) ±30kV (air / contact) IEC 61000-4-4 (EFT) 80A (5/50ns) IEC 61000-4-5 (Lightning) 20A (8/20µs) for any I/O-to-GND IEC 61000-4-5 (Lightning) 70A (8/20µs) for VDD-to-GND
- For low operating voltage applications: 5V maximum
- Low capacitance : 1.8pF typical
- Fast turn-on and low clamping voltage
- Array of surge rated diodes with internal equivalent TVS diode
- Small package saves board space
- Solid-state silicon-avalanche and active circuit triggering technology
- Green part

# Applications

- Video graphics cards
- LAN application
- USB2.0 power and data lines protection
- Notebook and PC computers
- Monitors and flat panel displays

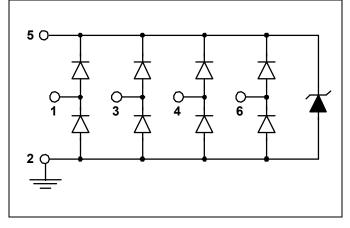
# Description

AZ1575-04S is a high-performance design which includes surge rated diode arrays to protect high-speed data interfaces. The AZ1575-04S has been specifically designed to protect sensitive components, which are connected to data and transmission lines, from over-voltage caused by Electrostatic Discharging (ESD), Electrical Fast Transients (EFT), and Lightning.

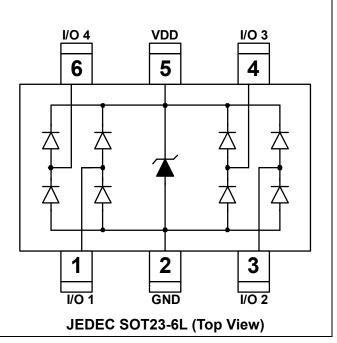
AZ1575-04S is a unique design which includes surge rated, low capacitance steering diodes and a unique design of clamping cell which is an equivalent TVS diode in a single package. During transient conditions, the steering diodes direct the transient to either the power supply line or to the ground line. The internal unique design of clamping cell prevents over-voltage on the power line, protecting any downstream components.

AZ1575-04S may be used to meet the ESD immunity requirements of IEC 61000-4-2, Level 4 ( $\pm$ 15kV air,  $\pm$ 8kV contact discharge).

## **Circuit Diagram**



# **Pin Configuration**





#### **Specifications**

Absoulte Maximum Ratings (T <sub>A</sub> = 25°C, unless otherwise specified)				
Parameter	Symbol	Rating	Unit	
Peak Pulse Current (t <sub>p</sub> =8/20µs, I/O-to-GND)	I <sub>PP-1</sub>	20	_	
Peak Pulse Current (t <sub>p</sub> =8/20µs, VDD-to-GND)	I <sub>PP-2</sub>	70	A	
Operating Voltage (VDD-to-GND)	V <sub>DC</sub>	5.5	V	
ESD per IEC 61000-4-2 (Air / Contact)	$V_{ESD}$	±30	kV	
Lead Soldering Temperature	T <sub>SOL</sub>	260 (10 sec.)	°C	
Operating Temperature	T <sub>OP</sub>	-55 to +125	°C	
Storage Temperature	T <sub>STO</sub>	-55 to +150	°C	

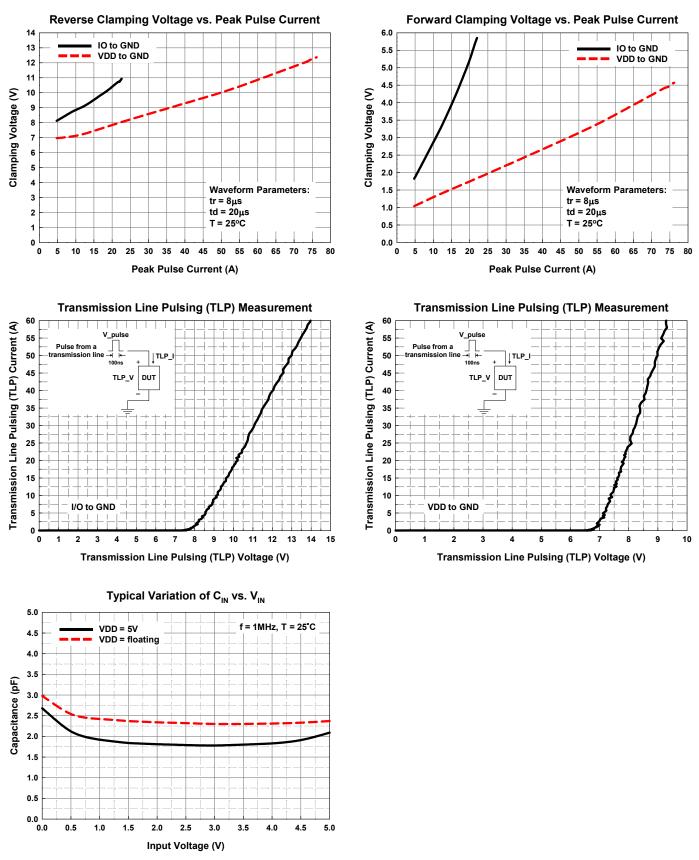
Electrical Characteristics						
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Reverse Stand-Off Voltage	V <sub>RWM</sub>	Pin-5 to pin-2, T= 25 °C.			5	V
Reverse Leakage Current	I <sub>Leak</sub>	$V_{RWM}$ = 5V, T= 25 °C, pin-5 to pin-2.			1	μA
Channel Leakage Current	I <sub>CH-Leak</sub>	$V_{pin-5} = 5V$ , $V_{pin-2} = 0V$ , T= 25 °C, any I/O pin to GND.			1	μA
Reverse Breakdown Voltage	V <sub>BV</sub>	$I_{BV}$ = 1mA, T= 25 °C, pin-5 to pin-2.	5.8		8.5	V
Forward Voltage	V <sub>F</sub>	$I_F$ = 15mA, T= 25 °C, pin-2 to pin-5.	0.6		1.2	V
ESD Clamping Voltage –I/O (Note 1)	V <sub>CL_ESD_I/O</sub>	IEC 61000-4-2 +8kV ( $I_{TLP}$ = 16A), T = 25 °C, contact mode, any I/O pin to GND.		10		V
ESD Clamping Voltage –VDD (Note 1)	$V_{CL\_ESD\_VDD}$	IEC 61000-4-2 +8kV ( $I_{TLP}$ = 16A), T= 25 °C, contact mode, VDD pin to GND.		8		V
ESD Dynamic Turn on Resistance –I/O	R <sub>dynamic_I/O</sub>	IEC 61000-4-2, 0~+8kV, T=25 °C, contact mode, any I/O pin to GND.		0.14		Ω
ESD Dynamic Turn on Resistance –VDD	R <sub>dynamic_VDD</sub>	IEC 61000-4-2, 0~+8kV, T=25 °C, contact mode, VDD pin to GND.		0.05		Ω
Surge Clamping Voltage –I/O	V <sub>CL_surge_I/O</sub>	$I_{PP}$ =20A, $t_p$ =8/20µs, T= 25 °C, any I/O pin to GND.		11		V
Surge Clamping Voltage –VDD	V <sub>CL_surge_VDD</sub>	$I_{PP}$ =70A, t <sub>p</sub> =8/20µs, T= 25 °C,VDD pin to GND.		12		V
Channel Input	C	<b>V</b> <sub>pin-5</sub> <b>=5V,</b> V <sub>pin-2</sub> =0V, <b>V</b> <sub>IN</sub> <b>=2.5V</b> , f =1MHz, T= 25 °C, any I/O pin to GND.		1.8	2.5	pF
Capacitance	C <sub>IN</sub>	<b>V</b> <sub>pin-5</sub> =floated, V <sub>pin-2</sub> =0V, <b>V</b> <sub>IN</sub> =2.5V, f =1MHz, T=25 °C, any I/O pin to GND.		2.3	3	pF
Channel to Channel Capacitance	C <sub>I/O-to-I/O</sub>	<b>V<sub>IN</sub> =2.5V</b> , f =1MHz, T=25 °C, between I/O pins.		1.3	1.8	pF

Note 1: ESD Clamping Voltage was measured by Transmission Line Pulsing (TLP) System.

TLP conditions:  $Z_0$ = 50 $\Omega$ ,  $t_p$ = 100ns,  $t_r$ = 1ns.



# **Typical Characteristics**







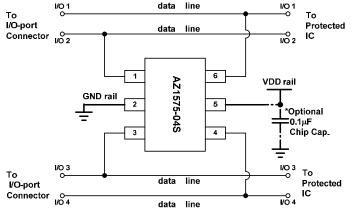
#### **Applications Information**

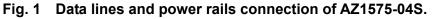
The AZ1575-04S is designed to protect four data lines and power rails from transient over-voltage (such as ESD stress pulse). The device connection of AZ1575-04S is shown in the Fig. 1. In Fig. 1, the four protected data lines are connected to the ESD protection pins (pin-1, pin-3, pin-4, and pin-6) of AZ1575-04S. The ground pin (pin-2) of AZ1575-04S is a negative reference pin. This pin should be directly connected to the GND rail of PCB (Printed Circuit Board). To get minimum parasitic inductance, the path length should keep as short as possible. In addition, the power pin (pin-5) of AZ1575-04S is a positive reference pin. This pin should directly connect to the VDD rail of PCB., then the VDD rail also can be protected by the power-rail ESD clamped circuit (not shown) of AZ1575-04S.

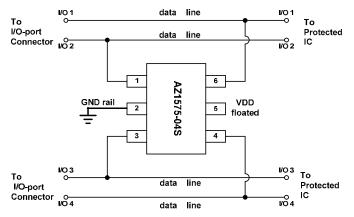
AZ1575-04S can provide protection for 4 I/O signal lines simultaneously. If the number of I/O signal lines is less than 4, the unused I/O pins can be simply left as NC pins.

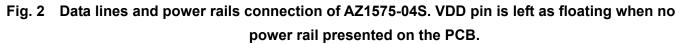
In some cases, systems are not allowed to be reset or restart after the ESD stress directly applying at the I/O-port connector. Under this situation, in order to enhance the sustainable ESD level, a  $0.1\mu$ F chip capacitor can be added between the VDD and GND rails. The place of this chip capacitor should be as close as possible to the AZ1575-04S.

In some cases, there isn't power rail presented on the PCB. Under this situation, the power pin (pin-5) of AZ1575-04S can be left as floated. The protection will not be affected, only the load capacitance of I/O pins will be slightly increased. Fig. 2 shows the detail connection.







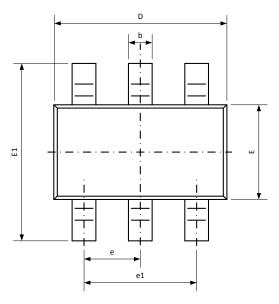




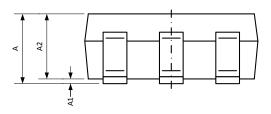
### **Mechanical Details**

SOT23-6L Package Diagrams

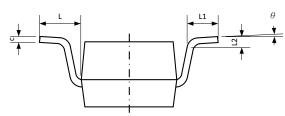
TOP VIEW



#### SIDE VIEW



#### END VIEW



Package D	imensions
	Millimeters

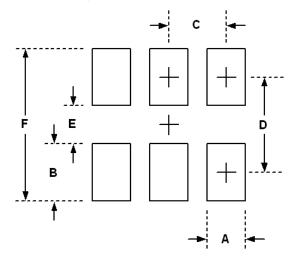
Symbol	Millimeters			
Symbol	Min.	Max.		
Α	-	1.25		
A1	0.00	0.10		
A2	0.90	1.20		
b	0.30 0.50			
С	0.08 0.21			
D	2.72 3.12			
ш	1.40	1.80		
E1	2.60 3.00			
е	0.95 BSC			
e1	1.90 BSC			
L1	0.30 0.60			
Ц	0.70 REF			
L2	0.25 BSC			
θ	0	8		

#### Notes:

- This dimension complies with JEDEC outline standard MO-178 Variation AB.
- Dimensioning and tolerancing per ASME Y14.5M-1994.
- All dimensions are in millimeters.



#### Land Layout

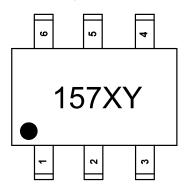


Dimensions					
Index Millimeter Inches					
А	0.60	0.024			
В	1.10	0.043			
С	0.95	0.037			
D	2.50	0.098			
E	1.40	0.055			
F	3.60	0.141			

Notes:

This LAND LAYOUT is for reference purposes only. Please consult your manufacturing partners to ensure your company's PCB design guidelines are met.

#### Marking code



Part Number	Marking Code	
AZ1575-04S.R7G	157VV	
(Green Part)	157XY	

Note : Green means Pb-free, RoHS, and Halogen free compliant.

157 = Device Code X = Date Code Y = Control Code

# **Ordering Information**

PN#	Material	Туре	Reel size	MOQ	MOQ/internal box	MOQ/carton
AZ1575-04S.R7G	Green	T/R	7 inch	3,000/reel	4 reels=12,000/box	6 boxes=72,000/carton



#### **Revision History**

Revision	Modification Description		
Revision 2021/04/28	Formal Release.		